## Quantum behavior in nanoscale ballistic recti ers and arti cial materials

A. Lofgren, I. Shorubalko, P.Om ling, and A.M. Song<sup>1,2</sup>,

<sup>1</sup>Solid State Physics and Nanom eter Consortium,

Lund University, 221 00 Lund, Sweden

<sup>2</sup>Department of Electrical Engineering and Electronics,

UM IST, Manchester M 60 1QD, UK

(Dated: March 22, 2024)

## Abstract

Low-tem perature experiments are performed on novel nanoscale nonlinear devices (ballistic recti ers) as well as nano-structured articial materials, fabricated from an InP/InG aAs quantum well wafer. A DC output is generated between the lower and upper contacts of these devices, when an AC voltage is applied between the left and right contacts. As the temperature is lowered from room temperature, the DC output voltage of the ballistic recti ers gradually changes from negative to positive. Since the negative output at high temperatures has been well understood in the framework of the classical ballistic electron transport, our results indicate that the electron transport comes into a new physical regime at low temperatures. Furthermore, we not that at even lower temperatures, the devices generate a pronounced oscillatory output as a function of the applied bias. Very similar phenomena are observed in the articial nanomaterials, suggesting the existence of a common mechanism. We present a simple model based on quantum transport, which explains the key phenomena that we have observed at low temperatures.

PACS numbers: 7323Ad, 7350Fq, 73.40Ei, 81.05Zx

The rapidly advancing nanotechnology has made it possible to fabricate devices that are sm aller than the electron mean free path, le. In these devices, electrons are mainly scattered at device boundaries rather than by random ly distributed scatterers such as impurities and phonons, and it is the device geometry that largely determines the paths traced by the electrons and, hence, the electronic properties. Based on this so-called ballistic electron transport, new device functionalities can be generated by simply tailoring the device shape. Although most studies on the ballistic electron transport were carried out in the linear regim  $e_{l}^{1}$  m ore and m ore attention is paid to the non-linear regim  $e_{l}^{2,3,4,5,6,7,8,9,10}$  R evently, it was also realized that the sym metry of the device geometry can have a pronounced in uence on the nonlinear device properties. 2,3,4,5 One such example is the recently realized ballistic recti er, in which a triangular antidot was fabricated in a ballistic m icrom eter-sized cross junction. The triangular antidot breaks the sym metry of the device, and also serves as an arti cial scatterer, which de ects the ballistic electrons to a certain direction independent of the direction of the applied electric eld. The generated rectifying functionality has been shown to be so strong that when ballistic transport was realized at room temperature by fabricating nanom eter-sized ballistic recti ers, the sensitivity of microwave detection was found to be roughly as high as a commercial microwave diode. 11 Based on a similar working principle, arti cial functionalm aterials have been made by fabricating an array of nanom eter-sized triangular antidots. The obtained nanom aterials have also been demonstrated to operate at room tem perature and at frequencies up to at least 50 GHz. 12

A part from the prom ising potentials for real applications, the ballistic recti ers and the nanom aterials might produce pronounced quantum e ects at low temperatures. This is because the width of the channels, from which the ballistic electrons are ejected, is comparable to the electron Fermiwavelength. From the physics point of view, studying the in uence of geometric symmetries of nanodevices on the quantum electron transport in the nonlinear regime is important, and only very limited number of such experiments have been reported. In this work, we report on temperature dependent experiments performed on the nanometer-sized ballistic rectiers and nanomaterials. Surprisingly, reversed as well as oscillatory output is observed when the temperature, T, is su ciently lowered. This is in strong contrast to the case at room or high temperatures, where the experimental results have been well understood in the framework of the classical ballistic electron scattering. The results indicate that at lower temperatures, the electron transport in the devices has

come into a new physical regime. We also discover very similar phenomena in the nanostructured articial material. We propose a simple model, and show that the experimental results of the ballistic rectiers and the nanomaterials can be qualitatively explained in a unied physical picture based on the quantum electron transport.

Both the ballistic recti ers and the nanom aterials are fabricated from a modulation-doped In<sub>0:75</sub>G a<sub>0:25</sub>A s=InP heterostructure (details in Ref. 15), in which electrons are con ned to a two dimensional electron gas (2DEG) in a 9 nm thick quantum well located 40 nm below the surface. The patterns are de ned using standard electron beam lithography and wet chemical etching (details in Ref. 16). Figures 1 (a) and (b) show the scanning electron m icrographs of a typical ballistic recti er and a part of a typical nanom aterial m easured in the experiments. The dark triangular areas are etched down through the 2DEG layer, and serve as articial scatterers for the ballistic electrons. In both cases, there are four electrical contacts: left or source (S), right or drain (D), lower (L), and upper (U). The width of the source and drain channels of the ballistic recti er, shown in Fig. 1 (a), is about 100 nm, while the width of the upper and lower channels is about 500 nm. The triangular antidot is situated away from the center of the cross junction, which results in pronounced nonlinear e ects as will be discussed below. The nanom aterial, which we show the results from here, has a repetition period of 600 nm in the horizontal direction, and 300 nm in the vertical direction. Both the base and the height of the triangles are 150 nm. The device consists of a cross junction with four contacts, and the written pattern covers the whole area. The distance between the contacts is 45 m both between the source and the drain, and between the upper and the lower contacts. W ithout illum ination, the 2D EG has the following parameters: carrier concentrations of  $4.5 10^{15}$  m  $^2$  and  $4.7 10^{15}$  m  $^2$ , and m obilities of 45 m $^2$ =V s and 1.2 m $^2$ =V s, at T = 0.3 K and room temperature, respectively. Thus, the mean free path  $l_{\rm e}$  varies from 5 m at 0.3 K to 140 nm at room temperature. At room temperature, L is shorter than but comparable to the distance between the triangular antidot and the source or drain channel in the ballistic recti er, meaning that the electron transport is partially ballistic. Sim ilarly, the electron transport within one \unit cell" of the arti cial lattice in Fig. 1 (b), which largely determ ines the transport properties of the whole nanom aterial, is also partially ballistic at room tem perature. As the tem perature is lowered, the electron transport in both the ballistic recti er and one unit cell in the nanom aterial becom es purely ballistic.

The experiments are performed by applying a DC voltage,  $V_{\rm SD}$ , between the source and drain and measuring the DC output voltage,  $V_{\rm LU}$ , between the lower and upper contacts. Figure 2 shows the temperature dependence of the ballistic rectier. At room temperature,  $V_{\rm LU}$  is negative, which is consistent with the results of our previous experiments, which have been described by a model based on the classical ballistic transport. The output remains negative as long as the temperature is above about 70 K. However, starting from about  $T = 200 \, \text{K}$ , the curves show a clear trend of upward bending, and a pronounced output reversal is observed at temperatures below about 40 K. Even more surprisingly, when the temperature is below about 78 K, oscillatory behavior can be clearly identiced.

Separate experiments show that lower temperatures are needed to observe output reversal if the sample is illuminated by an LED before the measurements. After the illumination, the electron concentration is increased by up to 30% and the electron Fermiwavelength becomes shorter. A number of devices with dierent geometric parameters (from half to about twice the size in Fig. 1) have also been measured, and the general trend is that the larger the device, the lower the temperature at which the output reversal starts to be seen. Both facts suggest that quantume ects play an important role in causing the reversed and oscillatory output. This may be expected because the width of the source and drain channels, from which the ballistic electrons are ejected, is comparable to the electron Fermiwavelength.

Reversed and oscillatory output from a ballistic recti er was predicted very recently by F leischm ann and G eisel. The mechanism was attributed to the large dierence between the channel widths of the upward and downward electron transmissions from S and D in the ballistic recti er, i.e., the gap between the triangular antidot and the edge of the upper channel is much narrower than the gap between the triangle and the edge of the lower channel. They argued that when the applied voltage is small, the number of occupied modes of lateral quantum con nement in the (lower) wider gap may increase because of the applied voltage, while the number of occupied modes in the (upper) narrower gap remains constant due to the larger energy separation of the lateral con nement energy levels. This gives rise to the \normal" rectifying e ect ( $V_{\rm LU} < 0$ ). When the applied voltage is high enough to open up a new mode in the upper gap, however, the output  $V_{\rm LU}$  should undergo a change of sign, i.e., output reversal.

While the result predicted by the model appears to be in good agreement with the experimental results in Fig. 2, such mechanism for the output reversal does not seem to

exist in the nanom aterials shown in Fig. 1 (b). This is because that in a nanom aterial, the width of the channel, which the electrons have to pass to transmit upwards after being ejected from a narrow gap between two neighboring triangles in a vertical column, is identical to the channel width of the downward electron transmission. As a result, the changes in the occupied lateral connement modes in the channels of both upward transmissions and the downward transmissions are essentially identical. However, when measuring the nanom aterials with various geometric parameters, we observe very similar reversed as well as oscillatory output to that shown in Fig. 2. Figure 3 shows typical results measured from a nanom aterial, which are unexpected from the model in Ref. 18.

In Fig. 3, the output is \norm al" at room temperature, which has been understood in the fram ework of the classical ballistic transport. O utput reversal starts to be seen at temperatures as high as 204 K. A blow-up of the curve at T=42 K clearly shows an oscillatory output. A lso, similar to the case of the ballistic rections, the experiments show that the larger the gaps or the \lattice constants of the articial lattice, the lower the temperature at which output reversal starts to be seen. In samples with much larger gaps between neighboring triangles (not shown here), no output reversal is observed down to T=42 K. This again suggests that quantum exects play an important role. Furthermore, the striking similarities in the experimental results in the ballistic rections and the nanomaterials suggest the existence of a common physical process that gives rise to the phenomena.

To understand the output reversal and the oscillatory output, we noticed that the width of the source and drain channels in the ballistic recti er and the width of the gaps between neighboring triangles in a vertical column in the nanom aterial are all comparable to the electron Ferm i wavelength, which is about 35 nm in our samples. By taking into account of the nite depletion depth at the etched device boundaries, the real widths of the lateral quantum con nement are even narrower than those shown in Fig. 1.

To sim plify the presentation of our model, we rst consider the articial nanomaterial. At high temperatures, the transverse quantum con nement modes in the gaps between neighboring triangles in a vertical column cannot be well resolved due to the broad Ferm i-D irac distribution. The angular distribution of electrons ejected from a gap is not uniform but, to some extent, collimated, 20,21,22,23, as schematically shown in Fig. 4. The pattern of the angular distribution in the nanomaterial is tilted upwards a little because the geometry of each gap between the two neighboring triangles is asymmetric. 23,24 From the angular distribution in the nanomaterial is tilted upwards as a little because the geometry of

tribution, one anticipates that the triangular scatterer im mediately on the right will deect m ost of the electrons downwards, while fewer electrons can transmit upwards without being scattered by the triangle. This may appear to result in an accumulation of electrons in the lower contact, and consequently induce a negative output voltage  $V_{L\,U}$ . However, this certainly cannot happen if no voltage is applied to the nanom aterial, since there are always the sam e number of transmissions along the opposite directions under the equilibrium condition. As is shown by the model of the ballistic recti er, 14 a nonzero output can only be generated by changes of the transmission coe cients caused by the applied voltage. For a nite negative  $V_{SD}$ , for example, the voltage drops, mainly at the openings and the exits of the gaps, $^{25}$  will cause an increase in the velocity components of the electrons along the S-D direction, while the velocity components in the perpendicular direction are virtually not a ected. This leads to smaller ejection angles of the electrons with respect to the S-D axis, and therefore an overall narrower angular pattern of the electron ow from S, as shown in Fig. 4 (b). Furtherm ore, the overall angular distribution of the ejected electrons should also level a bit as it tends to follow the direction of the electric eld. Such a collimation e ect induced by the applied voltage will clearly change the transm ission coe cients, resulting in m ore downward de ections of the electrons by the triangular scatterer, and fewer upward transm issions. This leads to a \norm al" negative output V<sub>LU</sub> as observed at high tem peratures in Fig. 3 (The probabilities for the electrons from L and U to transmit to the drain contact are not much a ected because the electric eld is only strong in the region very close to the gaps between neighboring triangles within a vertical column). If a positive  $V_{\text{SD}}$ is applied, the angular pattern of left-moving electrons from the gaps determines the net ow of carriers, and should be considered. Also in this case, the angular pattern becomes narrower and more leveled due to the applied electrice eld, and yields the same negative  $V_{LU}$  . This is also required by the geom etric symmetry with respect to the L-U axis.

At su ciently low tem peratures, the transverse modes in the gaps become well resolved. It is rather complex to determ ine the number of occupied modes in the gaps, because while the electron transport between neighboring triangular antidots is ballistic, the transport over the whole material is not. Furthermore, both electron back scatterings and multiple rejections from the antidots also seriously in uence the resistance. However, from the width of the gaps (about 100 nm) and the depletion depth (about 10 to 20 nm at each edge of the etched gaps), we estimate that there are between one and four occupied modes

at low temperatures. Separate resistance measurements on devices consisting of only a single narrow channel of sim ilar width have con mr ed the above estim ate on the number of occupied modes. Sim ilarly to the case of a quantum point contact in the adiabatic transport regime, each mode contributes to a specic angular pattern of electron ow from the gaps. The number of lobes (or branches) in the pattern of electron ow corresponds to the number of maximum s in  $j \neq l$  (where is the electron transverse wavefunction), as a direct result of the adiabatic transport. Therefore, for the Nth transverse mode, the number of lobes is N. Such branch-like patterns of electron ow were recently in aged using a low-tem perature scanning probe microscope. 26,27 In their experiments, additional ne fringes, separated by half the Ferm i wavelength, were discovered on the branch-like patterns, which are caused by coherent constructive and destructive backscattering of the electron waves. In general, such e ects of quantum phase coherence can be easily destroyed by increasing the temperature or applying a bias voltage29, which is the reason why the ne fringes were observed only at very low e ective electron temperatures. However, the branch-like electron ow survived at biases up to at least 3 mV (corresponding to 30 (40 K), because it is associated with the spacing between the transverse quantum con nem ent subband levels. In our experim ents, since the reversed and oscillatory output is observed at up to about 150 K and quite large biases, where the phase coherence is unlikely to exist over the distance between neighboring triangles, only the branch-like electron ow is considered and will be shown below to result in the observed phenomena.

For sim plicity, we assume that there is only one occupied mode at zero applied voltage, which corresponds to the angular pattern of the electron low shown in Fig. 5(a), but the following discussion applies to other (if not too large) numbers of initially occupied modes. The angular distribution in Fig. 5(a) is narrower than that in Fig. 4(a) because of the lower temperature. We note that  $l_e$  is not longer than a few unit cells of the articial lattice even at  $4.2~\mathrm{K}$ , in plying that the electron transport within a unit cell should be, to a large extent, representative of the overall behavior of the nanom aterial. If a small negative source-drain voltage is applied, the voltage-induced collimation elect leads to a narrower and more leveled angular pattern of the electron low, which is similar to the case at higher temperatures shown in Fig. 4(b). As a result, the downward transmissions of the electrons defected by the triangle increase, which gives rise to a negative output  $V_{\mathrm{LU}}$ . This explains the initial negative output voltage (or \norm all behavior) at low temperatures. If the

applied negative voltage is decreased further, the right-moving electrons from the left-hand side of a gap will eventually occupy the second lateral con nement mode,  $^{28}$  which gives rise to a two-branch angular distribution, on top of the single-branch pattern of electron ow of the rst occupied mode. In total, there are three lobes of electron ow as shown in Fig. 5 (c). The widening of the angular distribution clearly results in an increased probability (or percentage) for the electrons to transmit upwards, and a reduced probability of the downward transmissions. As shown by a detailed model and analysis in Ref. 14 (see Eq. (6) and the discussions), the output of a ballistic rection is determined by the relative changes of the transmission coecients, T=T, rather than the absolute values of the changes in the transmission coecients. This should be true for the articial material as well, because of the similarities between a ballistic rection and a unit cell of the articial material. Therefore, the increased probability (or percentage) for the electrons to transmit upwards and the reduced probability of the downward transmissions, which are discussed above and illustrated in Fig. 5 (c), will lead to an increase in  $V_{\rm LU}$  and may even cause the output reversal (from negative to positive) as observed in Fig. 3 in the intermediate  $V_{\rm SD}$  range.

If the negative applied voltage is decreased further, the applied voltage or electric eld should again cause the narrowing and leveling of the overall angular pattern of the electron ow as shown in Fig. 5 (d). The right-moving electrons hence have more and more chance to be scattered downwards by the triangle on the right-hand side, and this contributes again to a decrease in  $V_{LU}$ . The voltage-induced collination electrons is more pronounced at lower temperatures, since the average kinetic energy of the electrons is smaller and it is easier to reduce the ejection angle of an electron at a given voltage drop across the gaps. At su ciently low temperatures the downward bending of the curve may be strong enough to cause negative output again, and therefore gives rise to an overall oscillatory output, which is in good agreement with the experimental data in Fig. 3.

The electron transport in the ballistic recti er is quite sim ilar to that in the nanom aterial discussed above. At high tem peratures, the collimation electrons ejected by a nite negative applied voltage narrows the angular distribution of the electrons ejected out of S, as shown in Fig. 4(d). This enhances the probability for the electrons to be dejected downwards by the triangular antidot, and decreases the probability of the upward electron transmissions, leading to the \normal" negative output  $V_{LU}$ . At su ciently low temperatures, also similar to the case of the articial nanomaterial, by decreasing the applied voltage  $V_{SD}$  from zero, the

angular distribution of the electrons ejected out of S changes alternately by subsequentially narrowing as shown in Fig. 5(f), widening(g), narrowing (h), due to the interplay between the electric eld induced collimation and the openings of additional lateral connement modes in the source channel. This results in oscillatory modulations to the transmission probabilities for the electrons to be transmitted upwards and downwards, and hence leads to an oscillatory output  $V_{\rm LU}$ .

Based on this model, it is easy to predict that at low temperatures the output reversal m ay well start showing up around  $V_{\rm SD} = 0$ . In the above discussion, it is assumed that the Ferm i energy at  $V_{\text{SD}} = 0$  lies well inbetween two transverse subbands, either in the source and drain channels of the ballistic recti er or in the gaps between neighboring triangular antidots in a vertical column in the nanom aterial. In reality, it is possible that the Fermi energy is just below the bottom of the next subband. Because of the nite broadening of the subband as well as the Ferm indirect distribution, the occupation of the higher subband is not an abrupt process. In this case, any nite negative applied voltage may greatly enhance the population of the high subband, and result in the broadening of the angular distribution of the ejected electrons and hence a reversed output starting right from  $V_{SD} = 0$ . Experim entally, we indeed observe such a phenom enon, and the low-tem perature curves in Figure 2 are such an example. Also, since the chance for the Fermi energy to be just below a transverse subband is relatively small, in most cases one should observe a \normal" negative output around  $V_{SD} = 0$ , which is indeed the case in our experiments where the devices are measured at dierent processes of cooling downs, which cause small variations in the electron concentration and therefore changes in the electron Ferm i energy.

Apart from the similarities in the results of the ballistic rectier and the nanomaterials, we notice that there are dierences between the temperature dependences in Figs. 2 and 3. This is not surprising because of the noticeable dierences between the ballistic rectier and the nanomaterial. So far, we have only discussed the electron scattering within one unit cell of the nanomaterial. While a unit cell should largely represent some of the key transport properties of the whole nanomaterial, long trajectories of the ballistic electron over more than one unit cells also play an important role in the determination of the output voltage  $V_{LU}$ , especially when the mean free path is long at low temperatures. The analysis of the detailed in uence of long trajectories of the inter-unit-cell scatterings is very complex and is not presented in this paper. Furthermore, as mentioned earlier, the large dierence in the

channel widths between the upward and downward transmissions in the ballistic rectier does not exist in the nanomaterial. Therefore, it is expected that the transport properties of the nanomaterial and the ballistic rectier can well have dierent temperature dependence.

To conclude, we have investigated the electron transport in nanoscale ballistic recti ers and nano-structured articialm aterials, from the classical ballistic transport regime at room temperature down to a new regime at low temperatures. Reversed and oscillatory outputs are observed. We present a model based on the quantum and adiabatic electron transport, which explains the key phenomena that we have observed at low temperatures, and the similarities in the output from the ballistic recti ers and the nanomaterials.

## A cknow ledgm ents

The authors are grateful to L. Sam welson for constant support and W. Seifert for providing us the InP/InG aAs material. We wish to thank I. Maximov for the technical help and H. Q. Xu for the discussions. This work was supported by the Swedish Research Council, the Swedish Foundation for Strategic Research, and the European Commission through LTR research projects Q-SW ITCH and NEAR.

Corresponding author. Em ail address: A Song@ um istac.uk

For reviews, see C.W. J. Beenakker and H. van Houten, Solid State Physics 44, 1 (1991); S. Datta, Electronic Transport in Mesoscopic Systems (Cambridge University Press, Cambridge, 1995).

<sup>&</sup>lt;sup>2</sup> A. Lorke, S.W immer, B. Jager, J.P. Kotthaus, W. Wegscheider, and M. Bichler, Physica B 249–251, 312 (1998).

<sup>&</sup>lt;sup>3</sup> A.M. Song, A. Lorke, A. Kriele, J.P. Kotthaus, W. Wegscheider, and M. Bichler, Phys. Rev. Lett. 80, 3831 (1998).

<sup>&</sup>lt;sup>4</sup> H.Linke, W. Sheng, A.Lofgren, H.Q.Xu, P.Omling, and P.E.Lindelof, Europhys. Lett. 44, 341 (1998).

<sup>&</sup>lt;sup>5</sup> H.Linke, T.E.Humphrey, A.Lofgren, A.O.Sushkov, R.Newbury, R.P.Taylor, and P.Omling, Science 286, 2314 (1999).

- <sup>6</sup> D.R.S.Cum m ing and J.H.Davies, Appl. Phys. Lett. 69, 3363 (1996).
- <sup>7</sup> K.S.Novoselov, Y.V.Dubrovskii, V.A.Sablikov, D.Y.Ivanov, E.E.Vdovin, Y.N.Khanin, V.A.Tulin, D.Esteve, and S.Beaumont, Europhys.Lett. 52, 660 (2000)
- <sup>8</sup> K. Hieke and M. Ulfward, Phys. Rev. B 62, 16727 (2000).
- <sup>9</sup> H.Q.Xu, Appl. Phys. Lett 78, 2064 (2001); 80, 853 (2002); I. Shorubalko, H.Q.Xu, I. Maxim ov, P.Om ling, L.Sam uelson, and W. Seifert, ibid. 79, 1384 (2001); I. Shorubalko, H.Q. Xu, I.Maxim ov, D.Nilson, P.Om ling, L.Sam uelson, and W. Seifert, IEEE Electron Device Letters, 23, 377 (2002)
- L.W orschech, B.W eidner, S.Reitzenstein, and A.Forchel, Appl. Phys. Lett. 78, 3325 (2001);
  L.W orschech, H.Q.Xu, A.Forchel, and L.Samuelson, ibid. 79, 3287 (2001)
- A.M. Song, P.Omling, L. Samuelson, W. Seifert, I. Shorubalko, and H. Zirath, Jpn. J. Appl. Phys. 40, L909 (2001).
- A.M. Song, P.Om ling, L. Sam uelson, W. Seifert, I. Shorubalko, and H. Zirath, Appl. Phys. Lett. 79, 1357 (2001).
- H. Ueno, K. Moriyasu, Y. Wada, S. Osako, H. Kubo, N. Mori, and C. Hamaguchi, Jpn. J. Appl. Phys. 38, 332 (1999).
- <sup>14</sup> A.M. Song, Phys. Rev. B 59, 9806 (1999).
- P.Ram vall, N.Carlsson, P.Om ling, L.Sam uelson, W.Seifert, M.Stolze, and Q.Wang, Appl. Phys.Lett. 68, 1111 (1996).
- I.M axim ov, Q.W ang, M.G raczyk, P.Omling, L.Samuelson, W. Seifert, and I.Shorubalko, In Proc. of 11<sup>th</sup> Internat. Conference on InP and Related Materials, 1999, (Institute of Electrical and Electronics Engineers, Davos, Switzerland), p. 237.
- Since the device fabrication cannot be perfect, the ballistic recti er and the articial material are not perfectly symmetric along the U-L axis. This causes that the observed output between the lower and upper contacts,  $V_{\text{output}}$ , at a given applied voltage  $V_{\text{SD}}$  is dierent from the output at  $V_{\text{SD}}$ . To eliminate this elect and focus on the nonlinear elect induced by the articial triangular antidot, we always extracted the elective output,  $V_{\text{LU}}$  ( $V_{\text{SD}}$ ) =  $V_{\text{output}}$  (+  $V_{\text{SD}}$ ) +  $V_{\text{output}}$  (-  $V_{\text{SD}}$ ) =2, and reported it throughout the paper. This is also equivalent to the case of applying an AC signal and measure the DC output. Note also that due to the series resistances of the ohmic contacts and the broad 2DEG regions between the contacts and source/drain channels, the real voltage drop on the device is much less than  $V_{\text{SD}}$ , which also depends on

- tem perature.
- <sup>18</sup> R.Fleischm ann and T.Geisel, Phys. Rev. Lett. 89, 16804 (2002).
- The dierent voltage ranges of the dierent curves shown in Fig. 3 are due to the fact that the experiments were carried out by sweeping the source-drain current to a xed range. At lower temperatures, the overall resistances were lower, resulting in smaller voltage ranges.
- <sup>20</sup> C.W.J.Beenakker and H. van Houten, Phys. Rev. B 39, 10445 (1989).
- L.W. Molenkamp, A.A.M. Staring, C.W. J. Beenakker, R. Eppenga, C.E. Timmering, and J.G.Williamson, C.J.P.M. Harmans, C.T. Foxon, Phys. Rev. B 41, 1274 (1990).
- <sup>22</sup> K.L.Shepard, M.L.Roukes, and B.P.Van der Gaag Phys. Rev. Lett. 68, 2660 (1992).
- <sup>23</sup> R.I. Homsey, J. Appl. Phys. 79, 9172 (1996)
- <sup>24</sup> R.Akis, D.K. Ferry and J.P.Bird, Phys. Rev. B 54, 17705 (1996).
- <sup>25</sup> S.U lreich and W. Zwerger, Superlattices Microstruct. 23, 719 (1998).
- M.A. Topinka, B.J. LeRoy, S.E.J. Shaw, E.J. Heller, R.M. Westervelt, K.D. Maranowski, and A.C. Gossard, Science 289, 2323 (2000).
- <sup>27</sup> R. Crook, C. G. Smith, M. Y. Simmons, and D. A. Ritchie, J. Phys. Cond. M at. 12, L735 (2000).
- L.P.Kouwenhoven, B.J. van Wees, C.J.P.M. Harmans, J.G.William son, H. van Houten, C.W.J.Beenakker, C.T. Foxon and J.J. Harris, Phys. Rev. B 39, 8040 (1989).
- <sup>29</sup> J.J.Lin and J.P.Bird, J.Phys.: Condens. M atter 14, R 501 (2002)

Figures

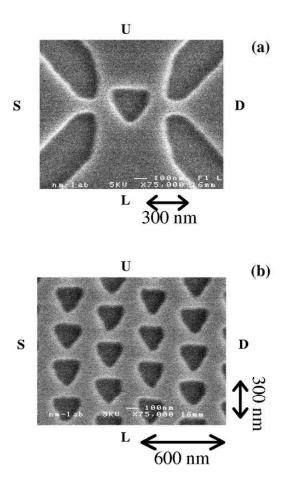


FIG. 1: Scanning electron m icrographs of (a) the ballistic recti er and (b) the articial nanom aterial measured in the experiments. The dark triangular areas are etched down through the layer of the two-dimensional electron gas, and serve as articial scatterers for the ballistic electrons. In both cases, there are four electrical contacts: left or source (S), right or drain (D), lower (L), and upper (U).

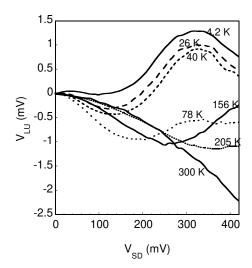


FIG .2: The output of the ballistic recti er,  $V_{\text{LU}}$ , as functions of the applied source-drain voltage,  $V_{\text{SD}}$ , m easured at di erent tem peratures.

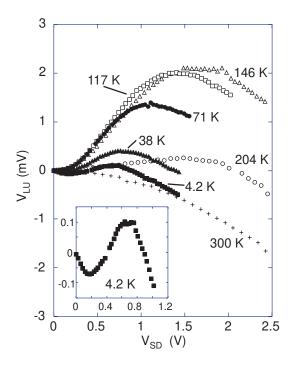


FIG. 3: The output of the artical nanom aterial  $V_{L\,U}$  as functions of the applied source-drain voltage  $V_{S\,D}$  m easured at dierent temperatures. The inset is a magnication of the 42 K data.

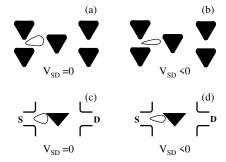


FIG. 4: Schem atic model of the classical ballistic electron transport at high tem peratures, for the \normal" negative output of the nanomaterial, shown in (a) and (b), and the ballistic rectier, shown in (c) and (d). Note that the patterns of the angular distribution in the nanomaterial are tilted a little bit upwards because the geometry of each gap between the two neighboring triangles is asymmetric.

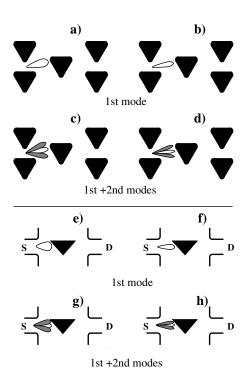


FIG. 5: Schem atic model for the output reversal and oscillatory output, in one unit cell of the arti cial nanom aterial (a)-(d) and in the ballistic recti er (e)-(h) at low tem peratures. As an exam ple, suppose that there is only one lateral con nement mode occupied in the narrow gaps between neighboring triangles in a vertical column when the applied voltage  $V_{\rm SD}$  is zero. As a result of the adiabatic transport at low temperatures, the electrons ejected out of the gaps have a narrow (rather than uniform) angular distribution (a). With decreasing  $V_{\rm SD}$ , the angular distribution rst becomes narrower due to the collimation elect induced by applied electriceld, and also becomes more horizontal to follow the direction of the electric eld, as shown in (b). By decreasing  $V_{SD}$  further, eventually the second lateral con nem ent mode becomes occupied, which gives rise to a two-branch angular distribution, on top of the single-branch pattern of electron ow of the rst occupied mode. In total, there are three lobes in the electron ow (c). The total angular distribution will become narrower again with continuing decreasing  $V_{\text{SD}}$  because of the voltage-induced collimation e ect (d). Overall, by decreasing the applied voltage  $V_{SD}$ from zero, the angular distribution of the electrons ejected out of the gaps changes alternately by subsequentially narrowing (b), widening (c), narrowing (d)... Consequently, both the upward and downward transmission probabilities for the electrons ejected from the gaps are oscillatory functions of  $V_{\text{SD}}$  , and this induces the oscillatory output  $V_{\text{LU}}$  as shown in Fig. 3. Sim ilar to the case of the articial nanomaterial shown in (a)-(d), by decreasing  $V_{SD}$  applied to the ballistic recti er from zero, the angular distribution of the electrons ejected out of S changes alternately by subsequentially narrowing (f), widening (g), narrowing (h),..., because of the interplay between the voltage-induced collimation and the openings of additional lateral con nement modes in the source channel.